



September 1983
Revised February 1999

MM74HCU04 Hex Inverter

General Description

The MM74HCU04 inverters utilize advanced silicon-gate CMOS technology to achieve operating speeds similar to LS-TTL gates with the low power consumption of standard CMOS integrated circuits.

The MM74HCU04 is an unbuffered inverter. It has high noise immunity and the ability to drive 15 LS-TTL loads. The 74HCU logic family is functionally as well as pin-out compatible with the standard 74LS logic family. All inputs

are protected from damage due to static discharge by internal diode clamps to V_{CC} and ground.

Features

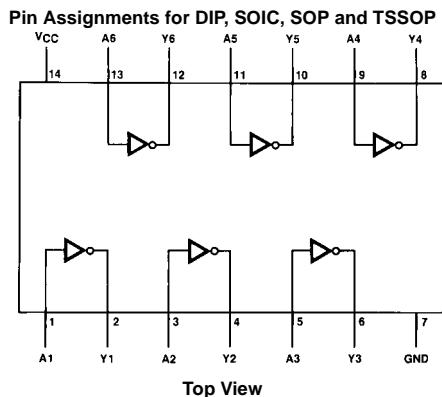
- Typical propagation delay: 7 ns
- Fanout of 15 LS-TTL loads
- Quiescent power consumption: 10 μ A maximum at room temperature
- Low input current: 1 μ A maximum

Ordering Code:

Order Number	Package Number	Package Description
MM74HCU04M	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150" Narrow
MM74HCU04SJ	M14D	14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
MM74HCU04MTC	MTC14	14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide
MM74HCU04N	N14A	14-Lead Plastic Dual-In-Lead Package (PDIP), JEDEC MS-001, 0.300" Wide

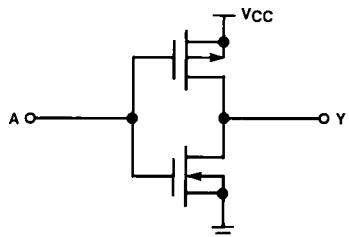
Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Connection Diagram



Top View

Schematic Diagram



MM74HCU04

Absolute Maximum Ratings ^(Note 1)				Recommended Operating Conditions				
(Note 2)								
Supply Voltage (V_{CC})	-0.5 to +7.0V					Min	Max	
DC Input Voltage (V_{IN})	-1.5 to V_{CC} +1.5V			Supply Voltage (V_{CC})	2	6	V	
DC Output Voltage (V_{OUT})	-0.5 to V_{CC} +0.5V			DC Input or Output Voltage (V_{IN} , V_{OUT})	0	V_{CC}	V	
Clamp Diode Current (I_{IK} , I_{OK})	±20 mA			Operating Temperature Range (T_A)	-40	+85	°C	
DC Output Current, per pin (I_{OUT})	±25 mA							
DC V_{CC} or GND Current, per pin (I_{CC})	±50 mA							
Storage Temperature Range (T_{STG})	-65°C to +150°C							
Power Dissipation (P_D)								
(Note 3)	600 mW							
S.O. Package only	500 mW							
Lead Temperature (T_L)								
(Soldering 10 seconds)	260°C							
DC Electrical Characteristics (Note 4)								
Symbol	Parameter	Conditions	V_{CC}	$T_A = 25^\circ\text{C}$		$T_A = -40$ to 85°C	$T_A = -55$ to 125°C	
				Typ		Guaranteed Limits		Units
V_{IH}	Minimum HIGH Level Input Voltage		2.0V		1.7	1.7	1.7	V
			4.5V		3.6	3.6	3.6	
			6.0V		4.8	4.8	4.8	
V_{IL}	Maximum LOW Level Input Voltage		2.0V		0.3	0.3	0.3	V
			4.5V		0.8	0.8	0.8	
			6.0V		1.1	1.1	1.1	
V_{OH}	Minimum HIGH Level Output Voltage	$V_{IN} = V_{IH}$ $ I_{OUT} \leq 20 \mu\text{A}$	2.0V	2.0	1.8	1.8	1.8	V
			4.5V	4.5	4.0	4.0	4.0	
			6.0V	6.0	5.5	5.5	5.5	
		$V_{IN} = \text{GND}$ $ I_{OUT} \leq 4.0 \text{ mA}$ $ I_{OUT} \leq 5.2 \text{ mA}$	4.5V	4.2	3.98	3.84	3.7	V
			6.0V	5.7	5.48	5.34	5.2	
V_{OL}	Maximum LOW Level Output Voltage	$V_{IN} = V_{IH}$ $ I_{OUT} \leq 20 \mu\text{A}$	2.0V	0	0.2	0.2	0.2	V
			4.5V	0	0.5	0.5	0.5	
		$V_{IN} = V_{CC}$ $ I_{OUT} \leq 6.0 \text{ mA}$ $ I_{OUT} \leq 7.8 \text{ mA}$	4.5V	0.2	0.26	0.33	0.4	V
			6.0V	0.2	0.26	0.33	0.4	
I_{IN}	Maximum Input Current	$V_{IN} = V_{CC}$ or GND	6.0V		±0.1	±1.0	±1.0	μA
I_{CC}	Maximum Quiescent Supply Current	$V_{IN} = V_{CC}$ or GND $I_{OUT} = 0 \mu\text{A}$	6.0V		2.0	20	40	μA
<p>Note 4: For a power supply of $5V \pm 10\%$ the worst case output voltages (V_{OH}, and V_{OL}) occur for HC at 4.5V. Thus the 4.5V values should be used when designing with this supply. Worst case V_{IH} and V_{IL} occur at $V_{CC} = 5.5\text{V}$ and 4.5V respectively. (The V_{IH} value at 5.5V is 3.85V.) The worst case leakage current (I_{IN}, I_{CC}, and I_{OZ}) occur for CMOS at the higher voltage and so the 6.0V values should be used.</p>								

AC Electrical Characteristics

$V_{CC} = 5V$, $T_A = 25^{\circ}C$, $C_L = 15 \text{ pF}$, $t_r = t_f = 6 \text{ ns}$

Symbol	Parameter	Conditions	Typ	Guaranteed Limit	Units
t_{PHL}, t_{PLH}	Maximum Propagation Delay		7	13	ns

AC Electrical Characteristics

$V_{CC} = 2.0V$ to $6.0V$, $C_L = 50 \text{ pF}$, $t_r = t_f = 6 \text{ ns}$ (unless otherwise specified)

Symbol	Parameter	Conditions	V_{CC}	$T_A = 25^{\circ}C$		$T_A = -40 \text{ to } 85^{\circ}C$	$T_A = -55 \text{ to } 125^{\circ}C$	Units
				Typ	Guaranteed Limits			
t_{PHL}, t_{PLH}	Maximum Propagation Delay		2.0V	49	82	103	120	ns
			4.5V	9.9	16	21	24	
			6.0V	8.4	14	18	20	
t_{TLH}, t_{THL}	Maximum Output Rise and Fall Time		2.0V	30	75	95	110	ns
			4.5V	8	15	19	22	
			6.0V	7	13	16	19	
C_{PD}	Power Dissipation Capacitance (Note 5)	(per gate)		90				pF
C_{IN}	Maximum Input Capacitance			8	15	15	15	pF

Note 5: C_{PD} determines the no load dynamic power consumption, $P_D = C_{PD} V_{CC}^2 f + I_{CC} V_{CC}$, and the no load dynamic current consumption, $I_S = C_{PD} V_{CC} f + I_{CC}$.

Typical Applications

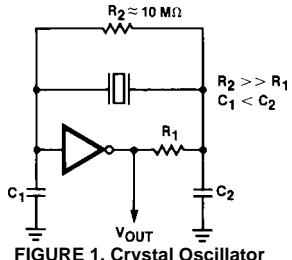


FIGURE 1. Crystal Oscillator

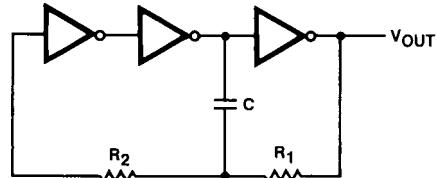


FIGURE 2. Stable RC Oscillator

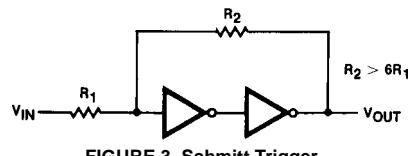
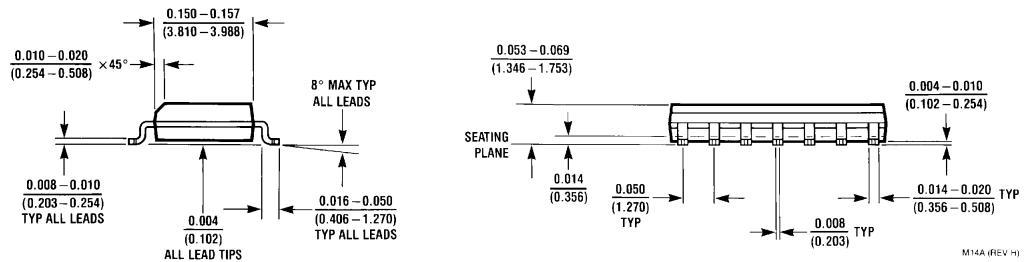
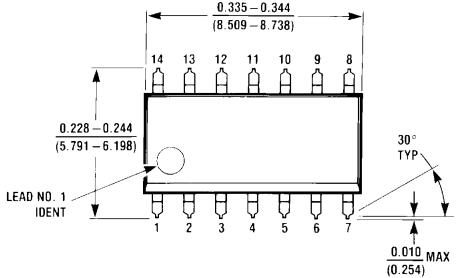


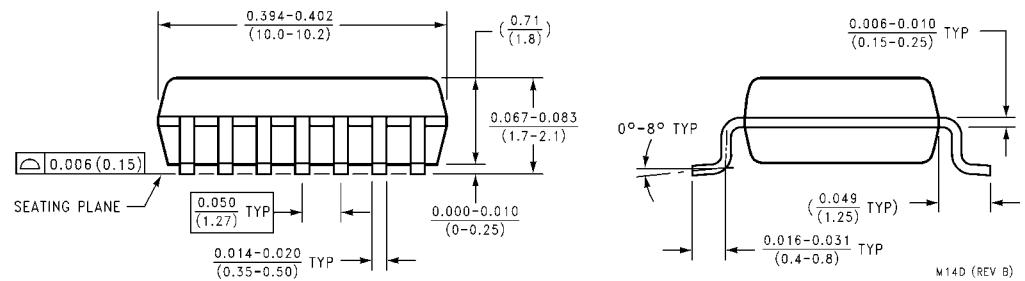
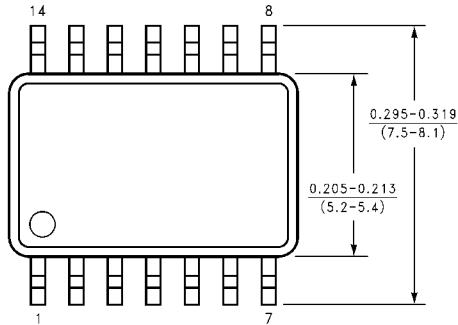
FIGURE 3. Schmitt Trigger

MM74HCU04

Physical Dimensions inches (millimeters) unless otherwise noted



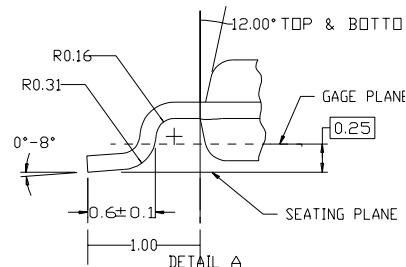
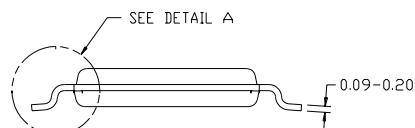
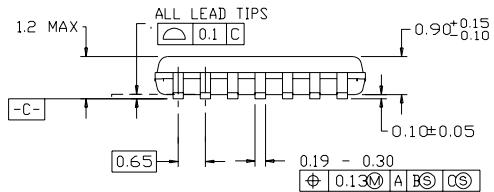
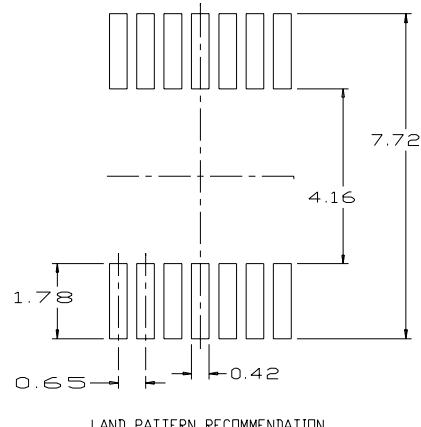
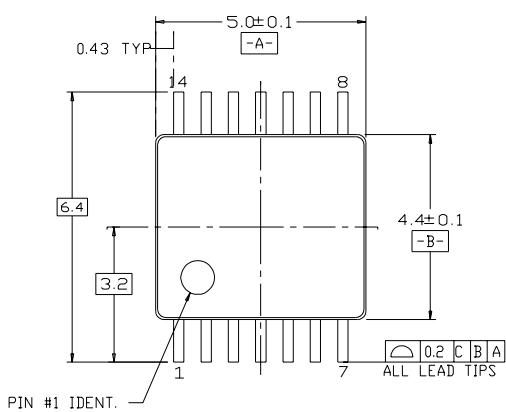
14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150" Narrow
Package Number M14A



14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
Package Number M14D

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)

14LD, TSSOP, JEDEC MO-153, 4.4MM WIDE

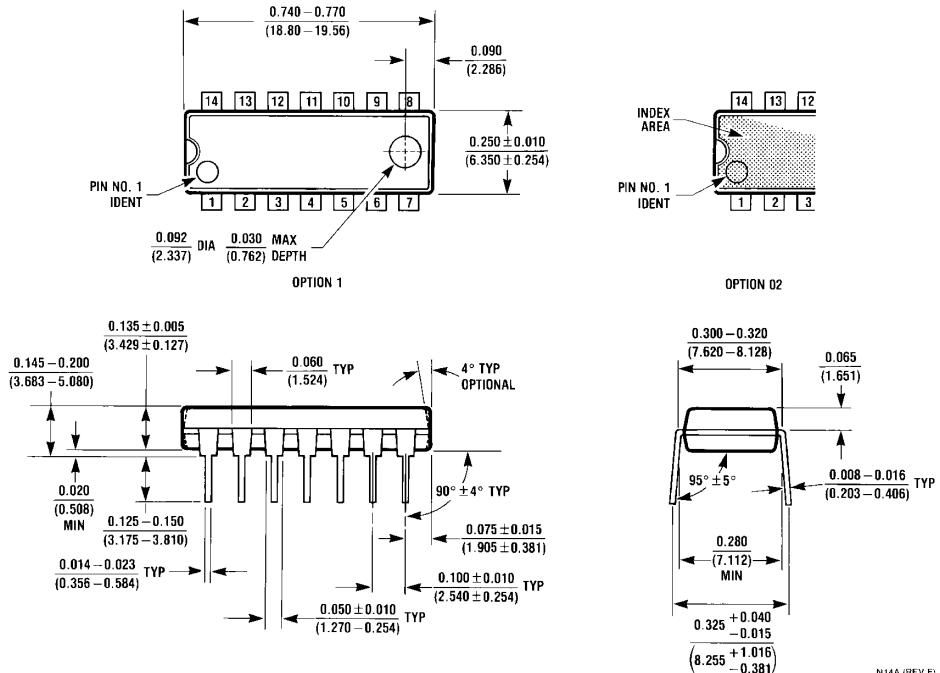


NOTES:

- A. CONFORMS TO JEDEC REGISTRATION MO-153, VARIATION AB, REF NOTE 6, DATED 7/93
- B. DIMENSIONS ARE IN MILLIMETERS
- C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS

14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide
Package Number MTC14

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide
Package Number N14A

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